

EM TXP Application Note Nr.: 3/1	Leica R. Ranner	Application: Cross polishing
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Market: Material inspection QA	Material: steel
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Complete process time: 40 min.

Process description: (benchmark values for this particular sample)

Sample embedded: **no** Holder: AFM holder 0-2mm (sample thickness **0.3mm**)

Tool inserts:	r.p.m	F value	Pump	E-W speed
diamond foils LA type: 9 μ , 6 μ , 3 μ , 1 μ , 0.5 μ , 0.1 μ foil carrier: steel	2000	5	8ml	0.35mm/s

